

**Search Notes**

Application/Control No.

10/611,971

Examiner

Tam Nguyen

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

3764

**SEARCHED**

Class	Subclass	Date	Examiner
482	51-53, 57-65	9/16/2005	TN
74	478.5	9/16/2005	TN
74	512,	9/16/2005	TN
74	562.5	9/16/2005	TN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
482	52,62	9/16/2005	TN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR